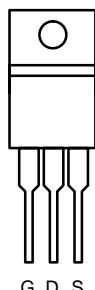


N-Channel 50-V (D-S), 175°C MOSFET

PRODUCT SUMMARY

$V_{(BR)DSS}$ (V)	$r_{DS(on)}$ (Ω)	I_D (A)
50	0.006	75

TO-220AB

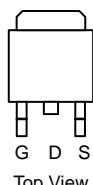


DRAIN connected to TAB

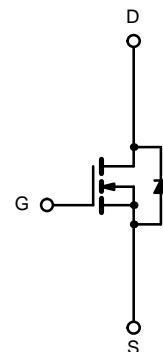
Top View

SUP75N05-06

TO-263



SUB75N05-06



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter	Symbol	Limit	Unit
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ($T_J = 175^\circ\text{C}$)	I_D	75 ^a	A
$T_C = 125^\circ\text{C}$		70	
Pulsed Drain Current	I_{DM}	240	
Avalanche Current	I_{AR}	75	
Repetitive Avalanche Energy ^b	E_{AR}	280	mJ
Power Dissipation	P_D	187 ^c	W
$T_A = 25^\circ\text{C}$ (TO-220AB and TO-263)		3.7	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to 175	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Limit	Unit
Junction-to-Ambient	R_{thJA}	40	°C/W
PCB Mount (TO-263) ^d		62.5	
Junction-to-Case	R_{thJC}	0.8	

Notes

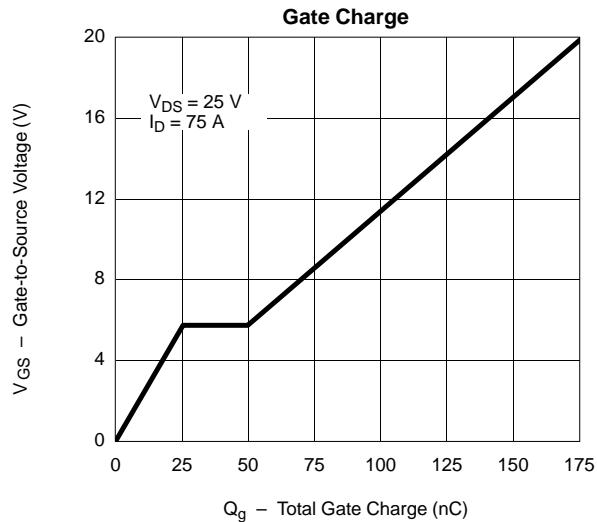
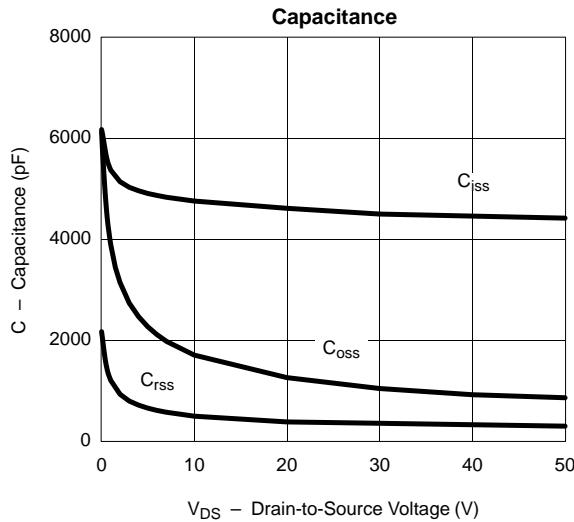
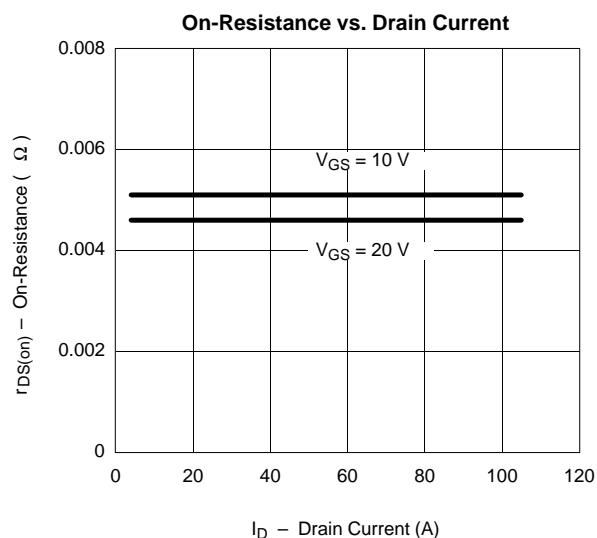
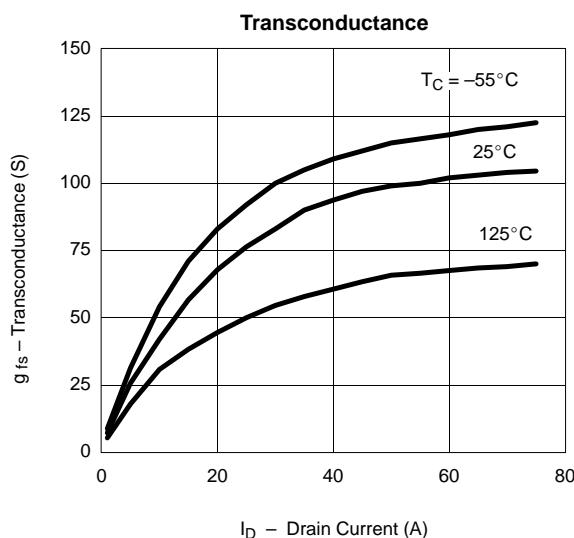
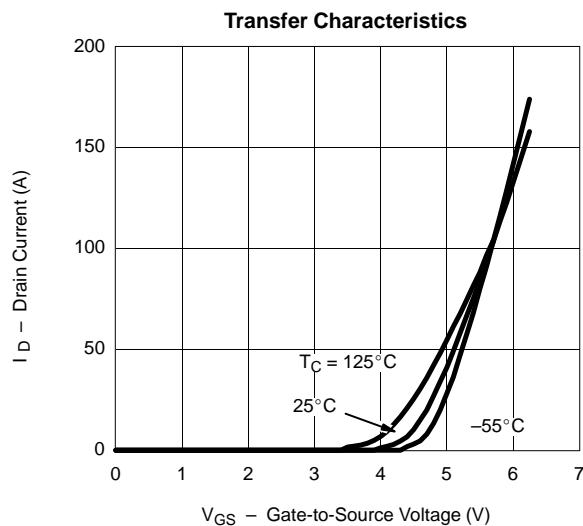
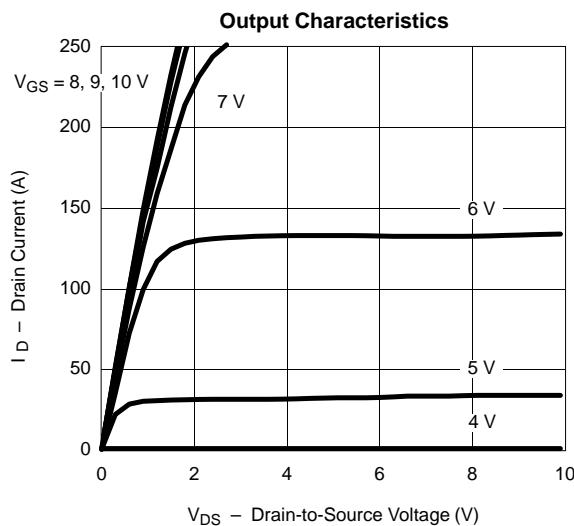
- a. Package limited.
- b. Duty cycle $\leq 1\%$.
- c. See SOA curve for voltage derating.
- d. When mounted on 1" square PCB (FR-4 material).

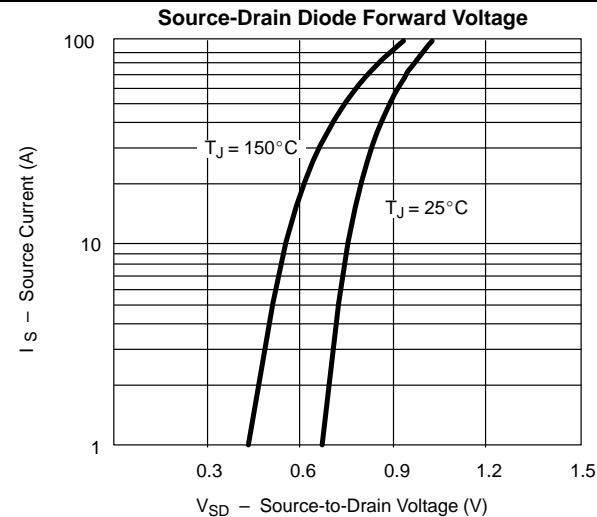
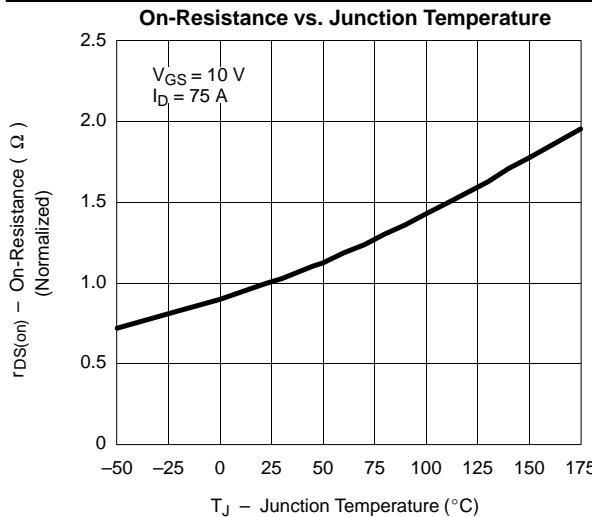
SPECIFICATIONS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	50			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	2.0		4.0	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$			1	
		$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125^\circ\text{C}$			50	μA
		$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 175^\circ\text{C}$			150	
On-State Drain Current ^a	$I_{D(\text{on})}$	$V_{DS} = 5 \text{ V}, V_{GS} = 10 \text{ V}$	120			A
Drain-Source On-State Resistance ^a	$r_{DS(\text{on})}$	$V_{GS} = 10 \text{ V}, I_D = 75 \text{ A}$		0.005	0.006	
		$V_{GS} = 10 \text{ V}, I_D = 75 \text{ A}, T_J = 125^\circ\text{C}$			0.010	Ω
		$V_{GS} = 10 \text{ V}, I_D = 75 \text{ A}, T_J = 175^\circ\text{C}$			0.012	
Forward Transconductance ^a	g_{fs}	$V_{DS} = 15 \text{ V}, I_D = 60 \text{ A}$	30			S
Dynamic^b						
Input Capacitance	C_{iss}	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$		4500		
Output Capacitance	C_{oss}			1100		pF
Reverse Transfer Capacitance	C_{rss}			360		
Total Gate Charge ^c	Q_g	$V_{DS} = 25 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 75 \text{ A}$		85	120	
Gate-Source Charge ^c	Q_{gs}			25		nC
Gate-Drain Charge ^c	Q_{gd}			25		
Turn-On Delay Time ^c	$t_{d(\text{on})}$	$V_{DD} = 25 \text{ V}, R_L = 0.33 \Omega$ $I_D \approx 75 \text{ A}, V_{GEN} = 10 \text{ V}, R_G = 2.5 \Omega$		20	40	
Rise Time ^c	t_r			20	100	
Turn-Off Delay Time ^c	$t_{d(\text{off})}$			50	100	ns
Fall Time ^c	t_f			20	40	
Source-Drain Diode Ratings and Characteristics ($T_C = 25^\circ\text{C}$)^b						
Continuous Current	I_S	$I_F = 75 \text{ A}, V_{GS} = 0 \text{ V}$ $I_F = 75 \text{ A}, \text{di/dt} = 100 \text{ A}/\mu\text{s}$			75	
Pulsed Current	I_{SM}				200	A
Forward Voltage ^a	V_{SD}			1.0	1.4	V
Reverse Recovery Time	t_{rr}			65	120	ns
Peak Reverse Recovery Current	$I_{RM(\text{REC})}$			5	8	A
Reverse Recovery Charge	Q_{rr}			0.16	0.48	μC

Notes

- a. Pulse test: pulse width $\leq 300 \mu\text{sec}$, duty cycle $\leq 2\%$.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)


TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

THERMAL RATINGS
